

RADIO TEST REPORT

Test Report No.: 28FE0180-HO-A

Applicant	:	DENSO CORPORATION
Type of Equipment	:	Electronic Key
Model No.	:	14ADF
Test regulation	:	FCC Part 15 Subpart C: 2008 Section 15.231
FCC ID	:	HYQ14ADF
Test Result	:	Complied

- This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc. 1.
- 2. The results in this report apply only to the sample tested.
- This sample tested is in compliance with above regulation. 3.
- The test results in this report are traceable to the national or international standards. 4
- 5 This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test:

February 14, 2008

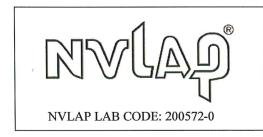
Tested by:

Kazufumi Nakai **EMC** Services

Approved by :

Makoto Kosaka

EMC Services



refer to the WEB address, http://uljapan.co.jp/emc/nvlap.htm

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MF060b (09.01.08)

Test report No.	: 28FE0180-HO-A			
Page	: 2 of 17			
Issued date	: February 21, 2008			
FCC ID	: HYO14ADF			

CONTENTS

PAGE

SECTION 1: Customer information	3
SECTION 2: Equipment under test (E.U.T.)	3
SECTION 3: Test specification, procedures & results	
SECTION 4: Operation of E.U.T. during testing	
SECTION 5: Radiated emission (Fundamental and Spurious Emission)	
APPENDIX 1: Photographs of test setup	
Radiated emission	
Worst case position	11
APPENDIX 2: Data of EMI test	
Automatically deactivate	
Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)	
-20dB Bandwidth	14
99% Occupied Bandwidth	15
Duty Cycle(Fundamental)	16
APPENDIX 3: Test Instruments	17

Test report No.	: 28FE0180-HO-A			
Page	: 3 of 17			
Issued date	: February 21, 2008			
FCC ID	: HYQ14ADF			

SECTION 1: Customer information

Company Name	:	DENSO CORPORATION
Address	:	1-1 Showa-cho, Kariya-shi, Aichi-ken, 448-8661, Japan

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.		
Type of Equipment	:	Electronic Key
Model No.	:	14ADF
Serial No.	:	1,2
Country of Manufacture	:	Japan
Receipt Date of Sample	:	February 13, 2008
Condition of EUT	:	Engineering prototype
		(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No modification by the test lab.

2.2 Product Description

Model No: 14ADF (referred to as the EUT in this report) is the Electronic Key.

Equipment Type	:	Transmitter
Clock frequency(ies)	:	CPU clock:8MHz SAW RESONATOR : 312.15MHz
Frequency of Operation	:	312.15MHz±10kHz
Type of modulation	:	FSK
Antenna Type	:	Built-in Type (Fixed)
Operating Voltage (Inner)	:	DC3.0V (Battery CR1632)

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification	: FCC Part 15 Subpart C : 2008, final revised on January 30, 2008
Title	: FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
	Section 15.231 Periodic operation in the band 40.66 - 40.70MHz
	and above 70MHz

FCC 15.31 (e)

This test was performed with the New Battery (DC 3.0V) and the constant voltage was supplied to the EUT during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

Test report No.: 28FE0180-HO-APage: 5 of 17Issued date: February 21, 2008FCC ID: HYQ14ADF

3.2 **Procedures and results**

Item	Test Procedure	Specification	Deviation	Worst margin	Results
Automatically Deactivate	<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> -</ic></fcc>	<fcc> Section 15.231(a)(1) <ic> RSS-210 A1.1.1</ic></fcc>	N/A	-	Complied
Electric Field Strength of Fundamental Emission	<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> RSS-Gen 4.8</ic></fcc>	<fcc> Section 15.231(b) <ic> RSS-210 A1.1.2</ic></fcc>	N/A	6.0dB 312.15MHz Horizontal, QP	Complied
Electric Field Strength of Spurious Emission	<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> RSS-Gen 4.9</ic></fcc>	<fcc> Section 15.205 Section 15.209 Section 15.231(b) <ic> RSS-210 A1.1.2, 2.6, 2.7</ic></fcc>	N/A	19.1dB 624.30MHz Vertical, QP	Complied
-20dB Bandwidth	<ic> -</ic>	<fcc> Section 15.231(c) <ic> Reference data</ic></fcc>	N/A	-	Complied
Conducted emission 7. AC powerline conducted emission measurements		<fcc> Section 15.207 <ic> RSS-Gen 7.2.2 C Mains.</ic></fcc>	-	N/A*1)	N/A
	Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission	Automatically DeactivateANSI C63.4:2003 13. Measurement of intentional radiators <ic>Electric Field Strength of Fundamental Emission<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> RSS-Gen 4.8Electric Field Strength of Spurious Emission<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> RSS-Gen 4.8Electric Field Strength of Spurious Emission<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> RSS-Gen 4.9-20dB Bandwidth<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> <ic> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> -20dB Bandwidth<fcc> ANSI C63.4:2003 13. Measurement of intentional radiators <ic> Conducted emission<fcc> ANSI C63.4:2003 7. AC powerline conducted emission measurements <ic></ic></fcc></ic></fcc></ic></ic></ic></ic></fcc></ic></fcc></ic></fcc></ic></fcc></ic>	Automatically DeactivateANSI C63.4:2003 13. Measurement of intentional radiators $$ $$ Section $I5.231(a)(1)$ $$ RSS-210 A1.1.1Electric Field Strength of Fundamental Emission $$ ANSI C63.4:2003 13. Measurement of intentional radiators $$ RSS-Gen 4.8 $$ Section 15.231(b) $$ RSS-210 A1.1.2Electric Field Strength of Spurious Emission $$ ANSI C63.4:2003 13. Measurement of intentional radiators $$ RSS-Gen 4.8 $$ Section 15.205 Section 15.205 Section 15.209 Section 15.209 Section 15.209 Section 15.231(b) $$ RSS-Gen 4.9-20dB Bandwidth $$ ANSI C63.4:2003 13. Measurement of intentional radiators $$ RSS-Gen 4.9-20dB Bandwidth $$ ANSI C63.4:2003 13. Measurement of intentional radiators $$ REference dataConducted emission $$ ANSI C63.4:2003 7. AC powerline conducted emission measurements $$ RSS-Gen 7.2.2	Automatically DeactivateANSI C63.4:2003 13. Measurement of intentional radiators <ic>Automatically DeactivateANSI C63.4:2003 (IC> SS-210 A1.1.1N/AElectric Field Strength of Fundamental EmissionSFCC> ANSI C63.4:2003 (IC> RSS-Gen 4.8SFCC> Section 15.231(b) <ic> RSS-210 A1.1.2N/AElectric Field Strength of Spurious EmissionSFCC> ANSI C63.4:2003 (IC> RSS-Gen 4.8SFCC> Section 15.205 Section 15.205 Section 15.201(b) <ic> RSS-210 A1.1.2N/AElectric Field Strength of Spurious EmissionSFCC> ANSI C63.4:2003 (IS Measurement of intentional radiators <ic> RSS-Gen 4.9SFCC> Section 15.205 Section 15.201(b) <ic> RSS-210 A1.1.2, 2.6, 2.7N/A-20dB BandwidthSFCC> ANSI C63.4:2003 (IC> RSS-Gen 4.9SFCC> Section 15.231(c) <ic> REference dataN/AConducted emissionSFCC> ANSI C63.4:2003 (IC> (IC> ANSI C63.4:2003 (IC> REference dataN/AConducted emissionSFCC> (IC> (IC> ANSI C63.4:2003 (IC> (IC> (IC> REference dataN/A</ic></ic></ic></ic></ic></ic>	Automatically DeactivateANSI C63.4:2003 13. Measurement of intentional radiators <ic>Electric Field Strength of Fundamental Emission<!--</td--></ic>

3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied	<ic></ic>	<ic></ic>	Conducted	N/A	N/A	N/A
	Band Width	RSS-Gen 4.6.1	RSS-210 A1.1.3				

Page	: 6	6 of 17
Issued d FCC ID		February 21, 2008 HYQ14ADF

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

	Conducted emission	R	adiated emiss (10m*)	sion	R	adiated emiss (3m*)	ion	Radi emis	sion
Test room		01.77	0.03 <i>(</i> 17)	0 000 (11)	01.77	2 0 2 <i>1</i> 1 2	0 000 ///	(3n	/
	150kHz-	9kHz-	30MHz-	300MHz-	9kHz-	30MHz-	300MHz-	1GHz-	18GHz-
	30MHz	30MHz	300MHz	1GHz	30MHz	300MHz	1GHz	18GHz	40GHz
No.1	3.7dB	3.1dB	4.7dB	4.4dB	3.2dB	3.7dB	4.4dB	5.9dB	6.1dB
semi-anechoic									
Chamber (±)									
No.2	3.7dB	-	-	-	3.2dB	4.3dB	3.9dB	5.9dB	6.1dB
semi-anechoic	5.7425				5. 2 4B		5.742	0.9 425	0.142
chamber (\pm)									
No.3	3.7dB				3.2dB	4.2dB	4.4dB	5.9dB	6.1dB
	5./ub	-	-	-	5.2UD	4.20D	4.40D	J.90D	0.10D
semi-anechoic									
chamber (±)									
No.4	3.7dB	-	-	-	3.2dB	4.2dB	4.4dB	5.9dB	6.1dB
semi-anechoic									
chamber (±)									

*10m/3m = Measurement distance

<u>Radiated emission test (3m)</u> The data listed in this test report has enough margin, more than the site margin.

Test report No.	: 28FE0180-HO-A
Page	: 7 of 17
Issued date	: February 21, 2008
FCC ID	: HYQ14ADF

3.5 Test Location

Telephone : +81 596 24	4 8116	Facsimile : +81 59	06 24 8124		
	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	IC4247	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	IC4247-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	IC4247-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	IC4247-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

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* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

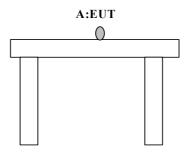
Test report No.	: 28FE0180-HO-A
Page	: 8 of 17
Issued date	: February 21, 2008
 FCC ID	: HYQ14ADF

SECTION 4: Operation of E.U.T. during testing

4.1 **Operating Modes**

The mode is used		 Normal use mode (for Automatically deactivate test only) Transmitting mode (for the other tests except for Automatically deactivate test)
Justification	:	The system was configured in typical fashion (as a customer would normally use it) for testing.

4.2 Configuration and peripherals



* Test data was taken under worse case conditions.

Description of EUT

No	Item	Model number	Serial number	Manufacturer	Remark
A	Electronic Key	14ADF	1 *1) 2 *2)	DENSO CORPORATION	EUT

*1) Used for all the tests except for Automatically deactivate test

*2) Used for Automatically deactivate test only

SECTION 5: Radiated emission (Fundamental and Spurious Emission)

5.1 **Operating environment**

Test place	: No.1 semi anechoic chamber
Temperature	: See data
Humidity	: See data

5.2 Test configuration

EUT was placed on a urethane platform of nominal size, 1.0m by 0.5m, raised 0.8m above the conducting ground plane. The EUT was set on the center of the urethane platform.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. A drawing of the set up is shown in the photos of APPENDIX 1.

5.3 Test conditions

Frequency range	: 30MHz-3200MHz
Test distance	: 3m
EUT position	: Top of Polyurethane platform
EUT operation mode	: See Clause 4.1

5.4 Test procedure

The Radiated Electric Field Strength intensity has been measured on a semi anechoic chamber with a ground plane and at a distance of 3m.

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver/spectrum analyzer.

Note: UL Japan, Inc.'s EMI Work procedures No. QPM05 and QPM15

	Pulse	emissions	Other emissions		
	Below or equal to 1GHz	Above 1GHz (FCC15.205)/(FCC15.231)	Below or equal to 1GHz	Above 1GHz (FCC15.205)/(FCC15.209)	
Detector	Peak with Duty factor	Peak and	QP	Peak and	
Туре		Peak with Duty factor		Average (Peak Detect)	
IF	T/R: BW 120kHz	PK: S/A:	T/R: BW 120kHz	PK: S/A:	
Bandwidth		RBW 1MHz,		RBW 1MHz,	
		VBW 1MHz		VBW 1MHz	
				AV: S/A:	
				RBW 1MHz,	
				VBW 10Hz	

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

With the position, the noise levels of all the frequencies was measured.

5.5 Results

Summary of the test results: Pass

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